Field Stop Trench IGBT 650 V, 40 A

FGAF40S65AQ

Description

Using novel field stop IGBT technology, ON Semiconductor's new series of field stop 4th generation of RC IGBTs offer the optimum performance for PFC applications and welder where low conduction and switching losses are essential.

Features

- Maximum Junction Temperature: $T_J = 175^{\circ}C$
- Positive Temperature Co-efficient for Easy Parallel Operating
- High Current Capability
- Low Saturation Voltage: $V_{CE(sat)} = 1.6 V (Typ.) @ I_C = 40 A$
- 100% of the Parts Tested for ILM (Note 1)
- High Input Impedance
- Fast Switching
- Tighten Parameter Distribution
- IGBT with Monolithic Reverse Conducting Diode
- This Device is Pb-Free and is RoHS Compliant

Applications

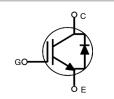
• PFC, Welder



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V _{CES}	Ι _C
650 V	40 A





ORDERING INFORMATION

See detailed ordering and shipping information on page 2 of this data sheet.

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PACKAGE MARKING AND ORDERING INFORMATION

Part Number	Device Marking	Package	Reel Size	Tape Width	Quantity per Tube
FGAF40S65AQ	FGAF40S65AQ	TO-3PF	-	-	30

Table 1. ABSOLUTE MAXIMUM RATINGS

Symbol	Description		FGAF40S65AQ	Unit
V _{CES}	Collector to Emitter Voltage		650	V
V _{GES}	Gate to Emitter Voltage		±20	V
	Transient Gate to Emitter Voltage		±30	V
Ι _C	Collector Current $@T_{C} = 25^{\circ}C$		80	А
		@ T _C = 100°C	40	1
I _{LM} (Note 1)	Pulsed Collector Current	@ T _C = 25°C	160	А
I _{CM} (Note 2)	Pulsed Collector Current		160	А
١ _F	Diode Forward Current	@ T _C = 25°C	40	А
		@ T _C = 100°C	20	А
I _{FM} (Note 2)	Pulsed Diode Maximum Forward Current		160	А
PD	Maximum Power Dissipation	@ T _C = 25°C	94	W
		@ T _C = 100°C	47	W
TJ	Operating Junction Temperature Range	•	–55 to +175	°C
T _{STG}	Storage Temperature Range		–55 to +175	°C
TL	Maximum Lead Temp. for Soldering Purpos	ses, 1/8" from case for 5 sec	300	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.
1. V_{CC} = 400 V, V_{GE} = 15 V, I_C = 160 A, R_G = 7 Ω, Inductive Load.
2. Repetitive rating: Pulse width limited by max. junction temperature.

Table 2. THERMAL CHARACTERISTICS

Symbol	Parameter	FGAF40S65AQ	Unit
R _{θJC} (IGBT)	Thermal Resistance, Junction to Case, Max.	1.6	°C/W
$R_{ hetaJA}$	Thermal Resistance, Junction to Ambient, Max.	40	°C/W

Table 3. ELECTRICAL CHARACTERISTICS OF THE IGBT (T_C = 25°C unless otherwise noted)

Symbol	Parameter	Test Conditions	Min	Тур	Max	Unit
OFF CHARACT	ERISTICS			1	1	
BV _{CES}	Collector to Emitter Breakdown Voltage	V _{GE} = 0 V, I _C = 1 mA	650	_	_	V
$\Delta BV_{CES} / \Delta T_{J}$	Temperature Coefficient of Breakdown Voltage	V _{GE} = 0 V, I _C = 1 mA	-	0.5	_	V/°C
I _{CES}	Collector Cut-Off Current	V _{CE} = V _{CES} , V _{GE} = 0 V	-	_	250	μA
I _{GES}	G-E Leakage Current	V _{GE} = V _{GES} , V _{CE} = 0 V	-	_	±400	nA
ON CHARACTE	RISTICS				1	
V _{GE(th)}	G-E Threshold Voltage	I_{C} = 40 mA, V_{CE} = V_{GE}	2.6	5.3	6.6	V
V _{CE(sat)}	Collector to Emitter Saturation Voltage	I _C = 40 A, V _{GE} = 15 V	-	1.6	2.1	V
		I _C = 40 A, V _{GE} = 15 V, T _C = 175°C	-	1.9	-	V
OYNAMIC CHA	RACTERISTICS		•			
C _{ies}	Input Capacitance	$V_{CE} = 30 V, V_{GE} = 0 V,$	-	2590	-	pF
C _{oes}	Output Capacitance	f = 1 MHz ´	-	35	-	pF
Cres	Reverse Transfer Capacitance		-	10	-	pF
WITCHING CH	IARACTERISTICS					
T _{d(on)}	Turn–On Delay Time	$V_{\rm CC}$ = 400 V, I _C = 10 A,	-	17.8	-	ns
Tr	Rise Time	$R_G = 6 \Omega$, $V_{GE} = 15 V$, Inductive Load, $T_C = 25^{\circ}C$	-	6.3	-	ns
T _{d(off)}	Turn–Off Delay Time		-	81.6	-	ns
Т _f	Fall Time		_	9.3	_	ns
Eon	Turn–On Switching Loss		-	132	-	μJ
E _{off}	Turn–Off Switching Loss		_	62	_	μJ
E _{ts}	Total Switching Loss		-	194	-	μJ
T _{d(on)}	Turn–On Delay Time	$V_{\rm CC} = 400 \text{ V}, \text{ I}_{\rm C} = 20 \text{ A},$	-	19.5	-	ns
Tr	Rise Time	$R_G = 6 \Omega$, $V_{GE} = 15 V$, Inductive Load, $T_C = 25^{\circ}C$	-	9.6	-	ns
T _{d(off)}	Turn-Off Delay Time		_	76.8	-	ns
Τ _f	Fall Time		_	7.4	-	ns
Eon	Turn–On Switching Loss		_	296	-	μJ
E _{off}	Turn-Off Switching Loss		_	111	-	μJ
E _{ts}	Total Switching Loss		-	407	-	μJ
T _{d(on)}	Turn-On Delay Time	$V_{CC} = 400 \text{ V}, \text{ I}_{C} = 10 \text{ A},$	-	17.5	-	ns
T _r	Rise Time	$R_G = 6 \Omega$, $V_{GE} = 15 V$, Inductive Load, $T_C = 175$ °C	-	6.8	-	ns
T _{d(off)}	Turn-Off Delay Time	1	-	88	-	ns
Τ _f	Fall Time	1	-	9.7	-	ns
Eon	Turn-On Switching Loss	1	-	285	-	μJ
E _{off}	Turn–Off Switching Loss	1	-	106	-	μJ
E _{ts}	Total Switching Loss	1	_	391	_	μJ

Table 3. ELECTRICAL CHARACTERISTICS OF THE IGBT (T_C = 25°C unless otherwise noted) Symbol Parameter Test Conditions Min Typ Max Unit

Symbol	Parameter	Test Conditions	Min	Тур	Max	Unit
SWITCHING C	CHARACTERISTICS					
T _{d(on)}	Turn-On Delay Time	$V_{CC} = 400 \text{ V}, \text{ I}_{C} = 20 \text{ A},$	-	19.1	-	ns
Tr	Rise Time	$R_G = 6 \Omega$, $V_{GE} = 15 V$, Inductive Load, $T_C = 175^{\circ}C$	-	11.2	-	ns
T _{d(off)}	Turn-Off Delay Time		-	81.6	-	ns
T _f	Fall Time		-	9.2	-	ns
Eon	Turn-On Switching Loss		-	552	-	μJ
E _{off}	Turn-Off Switching Loss		-	186	-	μJ
E _{ts}	Total Switching Loss		-	738	-	μJ
Qg	Total Gate Charge	$V_{CE} = 400 \text{ V}, \text{ I}_{C} = 40 \text{ A},$	-	75	-	nC
Q _{ge}	Gate to Emitter Charge	V _{GE} = 15 V	-	15	-	nC
Q _{gc}	Gate to Collector Charge		-	18	-	nC

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

Table 4. ELECTRICAL CHARACTERISTICS OF THE DIODE ($T_C = 25^{\circ}C$ unless otherwise noted)

Symbol	Parameter	Test Co	nditions	Min	Тур	Max	Unit
V _{FM}	Diode Forward Voltage	I _F = 20 A	T _C = 25°C	-	1.2	1.6	V
			T _C = 175°C	-	1.16	-	
E _{rec}	Reverse Recovery Energy	$I_{\rm F} = 20 {\rm A},$	T _C = 175°C	-	325	-	μJ
T _{rr}	Diode Reverse Recovery Time	dI _F /dt = 200 A/μs	$T_{C} = 25^{\circ}C$	-	274	-	ns
			T _C = 175°C	-	362	-	
Q _{rr}	Diode Reverse Recovery Charge		$T_{C} = 25^{\circ}C$	-	1596	-	nC
			T _C = 175°C	-	2651	-	

TYPICAL CHARACTERISTICS

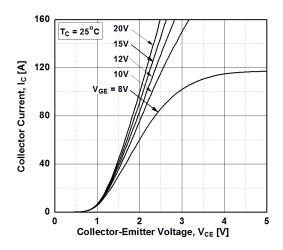


Figure 1. Typical Output Characteristics

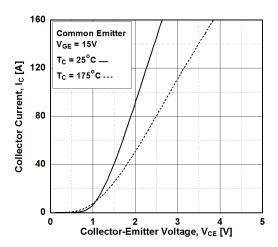


Figure 3. Typical Saturation Voltage Characteristics

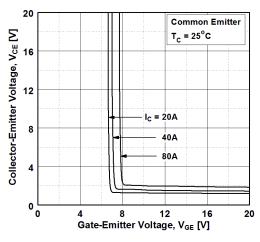


Figure 5. Saturation Voltage vs. V_{GE}

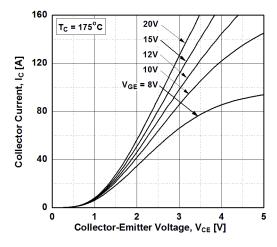


Figure 2. Typical Output Characteristics

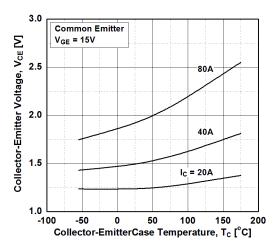


Figure 4. Saturation Voltage vs. Case Temperature at Variant Current Level

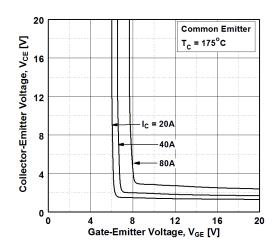


Figure 6. Saturation Voltage vs. V_{GE}

TYPICAL CHARACTERISTICS (Continued)

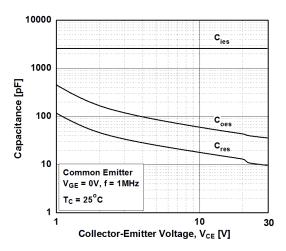
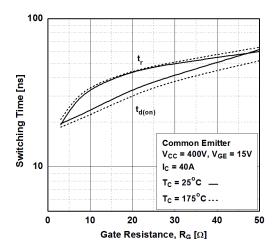


Figure 7. Capacitance Characteristics





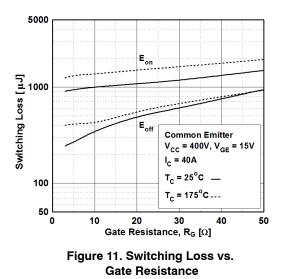


Figure 8. Gate Charge Characteristics

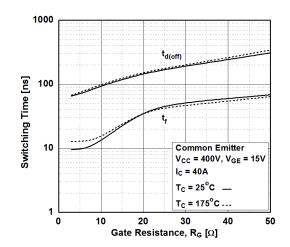
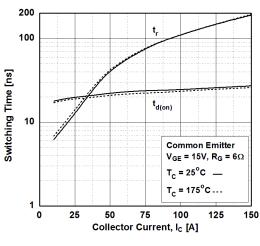
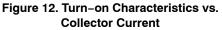


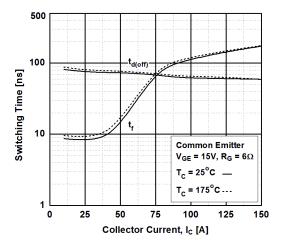
Figure 10. Turn-off Characteristics vs. Gate Resistance

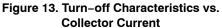




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TYPICAL CHARACTERISTICS (Continued)





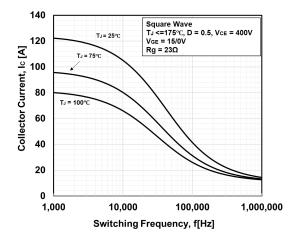


Figure 15. Load Current vs. Frequency

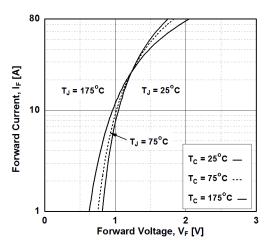


Figure 17. Forward Characteristics

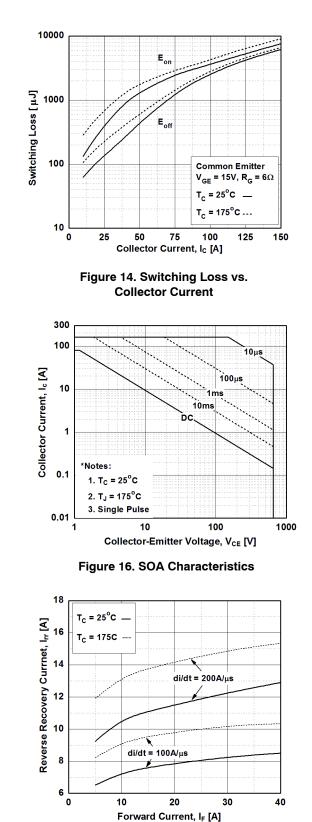


Figure 18. Reverse Recovery Current

TYPICAL CHARACTERISTICS (Continued)

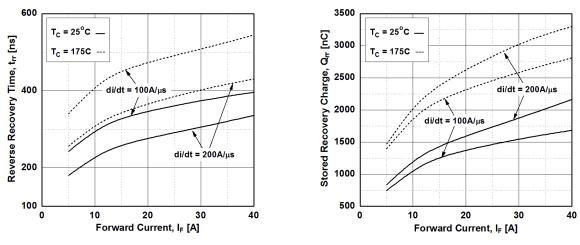


Figure 19. Reverse Recovery Time



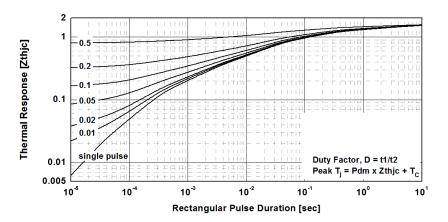
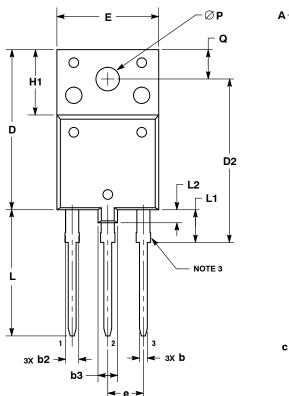


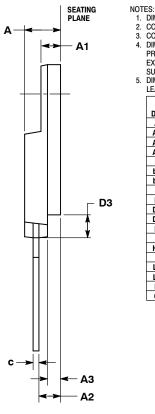
Figure 21. Transient Thermal Impedance of IGBT





DATE 09 JAN 2015





- 10TES:

 1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 2009.

 2. CONTROLLING DIMENSION: MILLIMETERS.

 3. CONTOUR UNCONTROLLED IN THIS AREA (6 PLACES).

 4. DIMENSIONS D AND E DO NOT INCLUDE MOLD FLASH OR GATE PROTRUSIONS. MOLD FLASH AND GATE PROTRUSIONS NOT TO EXCEED 0.13 PER SIDE. THESE DIMENSIONS ARE TO BE MEA-SURED AT THE OUTERMOST EXTREME OF THE PLASTIC BODY.

 5. DIMENSION b2 DOES NOT INCLUDE DAMBAR PROTRUSION. LEAD WIDTH INCLUDING PROTRUSION SHALL NOT EXCEED 2.20.

	MILLIN	IETERS
DIM	MIN	MAX
Α	5.30	5.70
A1	2.80	3.20
A2	3.10	3.50
A3	1.80	2.20
b	0.65	0.95
b2	1.90	2.15
b3	3.80	4.20
C	0.80	1.10
D	24.30	24.70
D2	24.70	25.30
D3	3.30	3.70
Е	15.30	15.70
е	5.35	5.55
H1	9.80	10.20
L	19.10	19.50
L1	4.80	5.20
L2	1.90	2.20
Р	3.40	3.80
Q	4.30	4.70

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